

December 2014

## FDMC8321LDC

# N-Channel Power Trench<sup>®</sup> MOSFET 40 V, 108 A, 2.5 m $\Omega$

#### **Features**

- Dual Cool<sup>TM</sup> Top Side Cooling PQFN package
- Max  $r_{DS(on)}$  = 2.5 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_D$  = 27 A
- Max  $r_{DS(on)}$  = 4.1 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 21 A
- High performance technology for extremely low r<sub>DS(on)</sub>
- RoHS Compliant

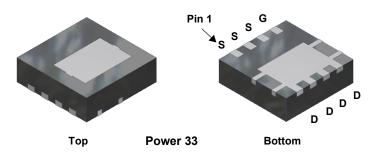
### **General Description**

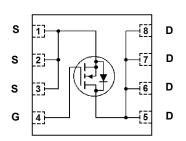
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process. Advancements in both silicon and Dual Cool  $^{TM}$  package technologies have been combined to offer the lowest  $r_{\text{DS(on)}}$  while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

### **Applications**

- Primary DC-DC Switch
- Motor Bridge Switch
- Synchronous Rectifier







### **MOSFET Maximum Ratings** T<sub>A</sub> = 25 °C unless otherwise noted

Symbol	Param	Parameter					
V <sub>DS</sub>	Drain to Source Voltage			40	V		
$V_{GS}$	Gate to Source Voltage			±20	V		
I <sub>D</sub>	Drain Current -Continuous	T <sub>C</sub> = 25 °C		108			
	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	27	Α		
	-Pulsed		(Note 4)	320			
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	181	mJ		
В	Power Dissipation	T <sub>C</sub> = 25 °C		56	W		
$P_{D}$	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	2.9	VV		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temper		-55 to +150	°C			

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	2.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	42	C/VV

### **Package Marking and Ordering Information**

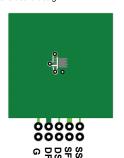
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
8321LD	FDMC8321LDC	Power33	13 "	12 mm	3000 units

#### **Thermal Characteristics**

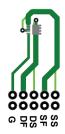
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	5.0	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	2.2	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	42	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	105	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	29	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	40	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	19	°C/M
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	23	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	30	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	79	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	17	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	12	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	16	

#### Notes:

1. R<sub>0,IA</sub> is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R<sub>0,IC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a. 42 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 105 °C/W when mounted on a minimum pad of 2 oz copper

- c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g. 200FPM Airflow, No Heat Sink,1 in  $^{\!2}$  pad of 2 oz copper
- h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in  $^2$  pad of 2 oz copper
- j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- $I.\ 200 FPM\ Airflow,\ 45.2 x 41.4 x 11.7 mm\ Aavid\ Thermalloy\ Part\ \#\ 10-L41 B-11\ Heat\ Sink,\ minimum\ pad\ of\ 2\ oz\ copper$
- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.
- 3.  $E_{AS}$  of 181 mJ is based on starting  $T_{J}$  = 25  $^{o}$ C, L = 3 mH,  $I_{AS}$  = 11 A,  $V_{DD}$  = 40 V,  $V_{GS}$  = 10 V. 100% tested at L = 0.1 mH,  $I_{AS}$  = 35 A.
- 4. Pulse Id measured at  $250\mu s$ , refer to Fig 11 SOA graph for more details.

### **Electrical Characteristics** T<sub>J</sub> = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	Off Characteristics					
$BV_{DSS}$	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V	40			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25 °C		39		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 32 V, V <sub>GS</sub> = 0 V			1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

### **On Characteristics**

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	1.7	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25 °C		-6		mV/°C
	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 27 \text{ A}$		2.0	2.5	
r <sub>DS(on)</sub>		$V_{GS} = 4.5 \text{ V}, I_D = 21 \text{ A}$		2.8	4.1	mΩ
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 27 A, T <sub>J</sub> = 125 °C		3.0	3.8	
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 27 \text{ A}$		126		S

### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V = 20 V V = 0 V		2832	3965	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, f = 1 MHz		777	1090	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1 101112		66	105	pF
$R_g$	Gate Resistance		0.1	0.7	2.5	Ω

### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 20 V, I <sub>D</sub> = 27 A,		13	23	ns
t <sub>r</sub>	Rise Time			5.5	11	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$		31	50	ns
t <sub>f</sub>	Fall Time			4.8	10	ns
$Q_{g(TOT)}$	Total Gate Charge at 10 V			43	60	nC
$Q_{g(TOT)}$	Total Gate Charge at 5 V	V - 20 V I - 27 A		22	31	nC
$Q_{gs}$	Total Gate Charge	$V_{DD} = 20 \text{ V, I}_{D} = 27 \text{ A}$		7.1		nC
$Q_{gd}$	Gate to Drain "Miller" Charge			6.1		nC

### **Drain-Source Diode Characteristics**

V	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2.3 \text{ A}$ (No	ote 2)	0.7	1.2	\/
V <sub>SD</sub> Source to Drain Diode Forward Voltage		$V_{GS} = 0 \text{ V}, I_S = 27 \text{ A}$ (No	ote 2)	8.0	1.3	, v
t <sub>rr</sub>	Reverse Recovery Time	-I <sub>F</sub> = 27 A, di/dt = 100 A/μs		31	50	ns
Q <sub>rr</sub>	Reverse Recovery Charge			11	20	nC

### Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

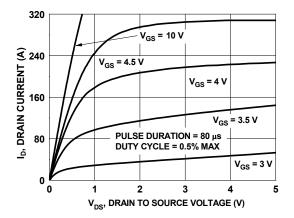


Figure 1. On Region Characteristics

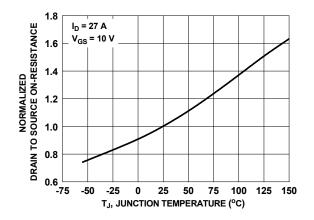


Figure 3. Normalized On Resistance vs Junction Temperature

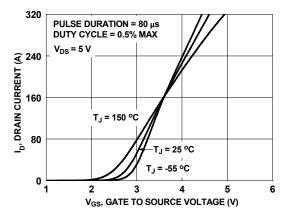


Figure 5. Transfer Characteristics

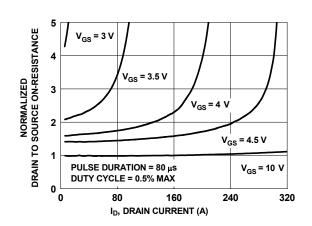


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

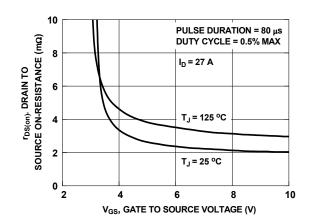


Figure 4. On-Resistance vs Gate to Source Voltage

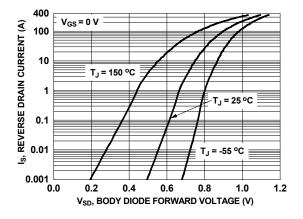


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

# Typical Characteristics $T_J$ = 25 $^{\circ}$ C unless otherwise noted

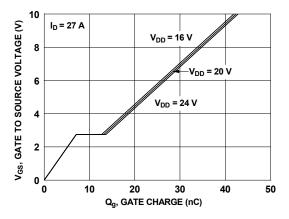


Figure 7. Gate Charge Characteristics

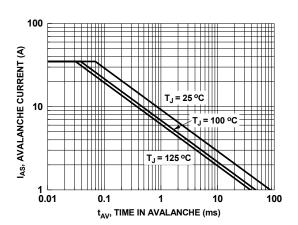


Figure 9. Unclamped Inductive Switching Capability

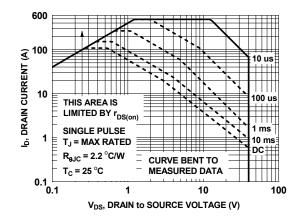


Figure 11. Forward Bias Safe Operating Area

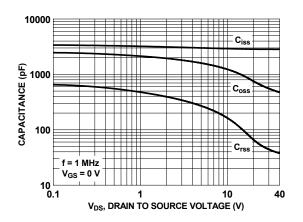


Figure 8. Capacitance vs Drain to Source Voltage

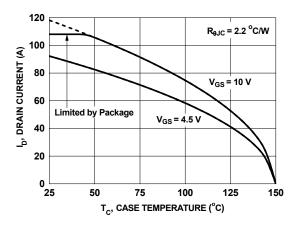


Figure 10. Maximum Continuous Drain Current vs Case Temperature

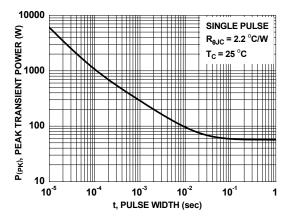


Figure 12. Single Pulse Maximum Power Dissipation

### **Typical Characteristics** $T_J = 25$ °C unless otherwise noted

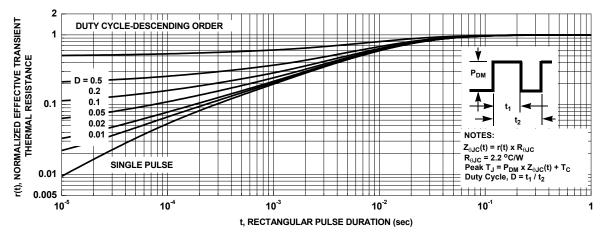
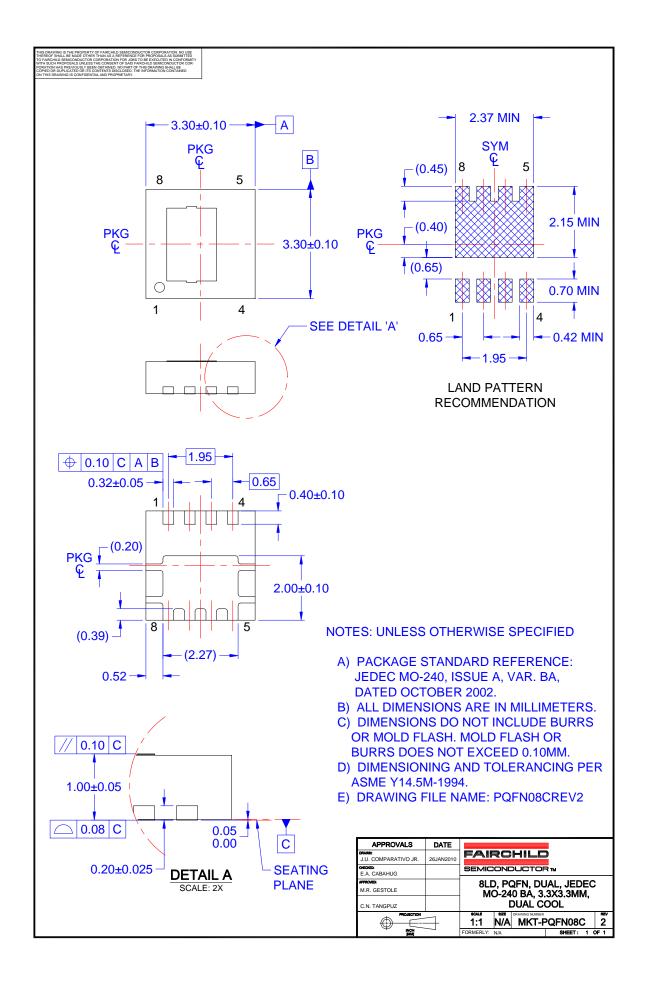


Figure 13. Junction-to-Case Transient Thermal Response Curve







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